## **TEST PHOTOGRAPHS** 17.

See following Attached Pages for setup photographs.

FCC ID: A3LSCHR950		HAC (RF EMISSIONS) TEST REPORT	SAMSUNG	Reviewed by: Quality Manager
HAC Filename:	Test Dates:	EUT Type:		Page 79 of 81
0Y1208281247.A3L	September 6-7, 2012	Portable Handset		Fage 79 01 01
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Figure 17-1 Ear Reference Point HAC Phantom Alignment

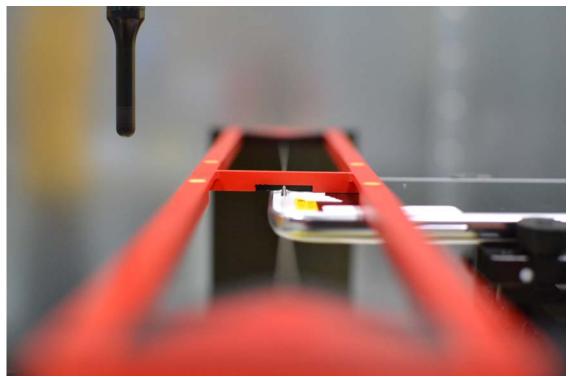


Figure 17-2 HAC Phantom Plane Alignment

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HAC Filename:	Test Dates:	EUT Type:		Page 80 of 81	
0Y1208281247.A3L	September 6-7, 2012	Portable Handset		Page 80 01 81	
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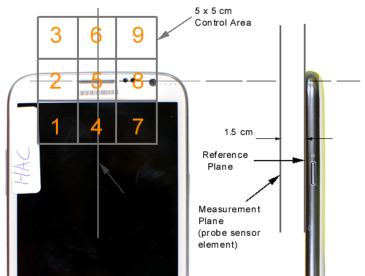


Figure 17-3 5x5 Scan grid above WD





Figure 17-4 E-Field WD Scan overlay

Figure 17-5 H-Field WD Scan overlay

	FCC ID: A3LSCHR950		HAC (RF EMISSIONS) TEST REPORT	SAMSUNG	Reviewed by: Quality Manager	
Γ	HAC Filename:	Test Dates:	EUT Type:		Page 81 of 81	
	0Y1208281247.A3L	September 6-7, 2012	Portable Handset		Fage of 01 of	
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